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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Masaru AMAI, et al.

International Application No.: PCT/JP2005/006675

International Filing Date: April 5, 2005

U.S. Serial No.: To Be Assigned

Group Art Unit: To Be Assigned

Filed: : Herewith

Examiner: To Be Assigned

For: SUBSTRATE CLEANING APPARATUS, SUBSTRATE CLEANING METHOD,
AND MEDIUM FOR RECORDING PROGRAM USED FOR THE METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure under 37 C.F.R. 1.56, Applicants are enclosing an Information Disclosure Citation Form (PTO-1449) which lists the documents noted in the International Search Report (ISR) filed herewith. According to the Search Report, U.S. Publication No. 2003/178047 is a family member of JP 2003-275696; U.S. Publication No. 2003/79764 is a family member of JP 2003-203892 and U.S. Publication No. 2002/189641 is a family member of JP 2003-1199.

It is respectfully requested that the cited documents be considered by the Examiner in the above-identified patent application and that the cited documents be made officially of record therein. It is further requested that a listing of the same appear on the face of any patent which may issue from this application.

Respectfully submitted,
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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT	ATTY. DOCKET 033082M353	SERIAL NO. To Be Assigned
	APPLICANT: Masaru AMAI, et al.	
	FILING DATE Herewith	GROUP ART UNIT To Be Assigned

U.S. PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE, IF APPROPRIATE
	AA	2003/178047	9/25/03	Sadao Hirae			
	AB	2003/79764	5/1/03	Keizo Hirose, et al.			
	AC	2002/189641	12/19/02	Masanobu Sato			
	AD						
	AE						
	AF						
	AG						

FOREIGN PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES NO
	AH	2003-275696	9/30/03	Japan			Abstract
	AI	2003-203892	7/18/03	Japan			Abstract
	AJ	2003-001199	1/7/03	Japan			Abstract
	AK	07-169725	7/4/95	Japan			Abstract
	AL						
	AM						
	AN						
	AO						
	AP						

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

AQ	
AR	
AS	

EXAMINER:	DATE CONSIDERED:
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.